

Sheet 1 of 2

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| Form PTO U.S. Patent and Trademark Office INFORMATION DISCLOSURE STATEMENT | Atty. Docket No. OGOSH35USA | Serial No. 10/543,103 |
| | Applicant: Hideo Takami et al. | |
| | 371 (c) Date: July 22, 2005 | Group Art Unit: 2812 |

U.S. PATENT DOCUMENTS

| Examiner Initial | | Document No. | Date | Name | Class | Subclass |
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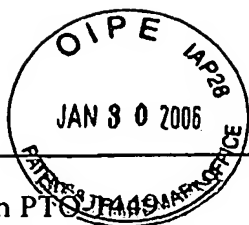
FOREIGN PATENT DOCUMENTS

| Examiner Initial | | Document No. | Date | Country | Translation | |
|------------------|--|----------------|---------|---------|---------------|----|
| | | | | | Yes | No |
| /WZ/ | | JP 2002-352483 | 12/2002 | Japan | Abstract only | X |
| /WZ/ | | JP 11-279752 | 10/1999 | Japan | Abstract only | X |
| /WZ/ | | JP 10-060634 | 3/1998 | Japan | Abstract only | X |
| /WZ/ | | JP 2002-038258 | 2/2002 | Japan | Abstract only | X |

Other Documents (including Author, Title, Date, Pertinent Pages, Etc.)

| | | |
|--|--|---|
| /WZ/ | | Patent Abstracts of Japan, 1 page English Abstract of JP 2002-352483, 12/2002 |
| /WZ/ | | esp@cenet database, 1 page English Abstract of JP 11-279752, 10/1999 |
| /WZ/ | | esp@cenet database, 1 page English Abstract of JP 10-060634, 3/1998 |
| /WZ/ | | esp@cenet database, 1 page English Abstract of JP 2002-038258, 2/2002 |
| Examiner /Weiping Zhu/ (04/13/2007) Date Considered 04/13/2007 | | |

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Sheet 2 of 2

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FOREIGN PATENT DOCUMENTS

| Examiner Initial | | Document No. | Date | Country | Translation | |
|------------------|--|----------------|--------|---------|---------------|----|
| | | | | | Yes | No |
| /WZ/ | | JP 2002-069624 | 3/2002 | Japan | Abstract only | X |
| /WZ/ | | JP 2000-178724 | 6/2000 | Japan | Abstract only | X |
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Other Documents (including Author, Title, Date, Pertinent Pages, Etc.)

| | | |
|----------|----------------------------|---|
| /WZ/ | | esp@cenet database, 1 page English Abstract of JP 2002-069624, 3/2002 |
| /WZ/ | | esp@cenet database, 1 page English Abstract of JP 2000-178724, 6/2000 |
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| | | |
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